



<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10625155	MITRA, PRADIP
	Examiner Nguyen, Helen	Art Unit 3736

Notes	Date	Examiner
Inventor search performed in PALM	7/6/2006	HQN
See EAST Search History	7/6/2006	HQN
STIC Search	7/6/2006	HQN
U.S. Patent and Trademark Office		Part of Paper No.: 20060630

<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10625155</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MITRA, PRADIP</p>
	<p>Examiner</p> <p>Nguyen, Helen</p>	<p>Art Unit</p> <p>3736</p>

Class	SubClass	Date	Examiner
600	473-475, 549	7/6/2006	HQN

U.S. Patent and Trademark Office	Part of Paper No.: 20060630
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